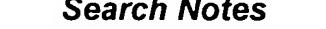


<b>Search Notes</b> 	<b>Application/Control No.</b>  10/764,854	<b>Applicant(s)/Patent under Reexamination</b>  OKMIANSKI ET AL.
	<b>Examiner</b>  David E. Martinez	<b>Art Unit</b>  2181

**SEARCHED**

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East see attached	8/28/2006	DM
710/15,18,29,30,33-35,52,57.ccls. 709/223-226.ccls. 711/135.ccls. with keywords and text search	8/28/2006	DM
Databases: US Patents, US PGPIUBS, USOCR, EPO, JPO, Derwent, IBM_TDB.	8/28/2006	DM
Niketa Palel	8/28/2006	DM

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
710	52,57,29	8/28/2006	DM
710	35	8/28/2006	DM
711	135	8/28/2006	DM
Databases: US Patents, US PGPUBS, USOCR, EPO, JPO, Derwent,		8/28/2006	DM